

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	09695228	MARKO ET AL.
	Examiner	Art Unit
	Tran, Hai	2623

SEARCHED

Class	Subclass	Date	Examiner
348	441	02/02/2007	HVT
370	389	02/02/2007	HVT

SEARCH NOTES

Search Notes	Date	Examiner
Updated Search	02/002/2007	HVT
Updated Search	08/20/2010	FEH
Considered 101 and 112 issues	08/20/2010	FEH
Inventorship Searched	08/20/2010	FEH

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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